

(a)



Figure 12. SEM micrograph of etched surfaces of powder 2 PIT tapes treated for a total of 100 h with (a) fast cooling and (b) slow cooling performed in all the sintering steps.

characteristics. For powder with high excess of Cu, the Bi-2223 formation rate is observed to increase initially. As reaction proceeds, however, the difference in Bi-2223 content amongst the three precursors is reduced and the %Bi-2223 is virtually indistinguishable after 60 h of processing. In addition, an optimum heat treatment schedule determined for the base powder in a previous study is found to remain valid even for precursors containing excess Cu. However, since any  $J_c$  enhancement in fully processed tapes made from excess Cu precursors is not substantial, it is not advisable to add a high amount of Cu which can result in secondary phases. In the present study, powder 2 is the best compromise in having a fast reaction rate while not affecting the secondary-phase content significantly.

Beneficial effects of slow cooling have been confirmed in PIT tapes made with powders 2 and 3. It is found that in all the heat treatment sequences examined in this study, the incorporation of one or more slow-cooling steps is effective in improving the  $J_c$  by a factor of two to four. The optimum treatments determined using results from a previous fast-cooling study can be utilized for the slowcooling processes. However, modifications have to be made to compensate for the faster reaction kinetics of precursors with excess Cu. While both the 25 25 50 and 12-12-26-50 schedules performed equally well in samples containing precursor with no Cu addition and subjected to fast cooling only, the latter schedule appears to be better suited for the faster kinetics of precursors with Cu additions. Because of the increased reaction rate, highest  $J_c$  was obtained after 50 h of sintering time and slow cooling during the final step. If slow cooling is performed in every sintering interval,  $J_c$  reaches a maximum value after 50 h of accumulated sintering and starts to decrease due to insufficient amount of liquid phase to heal the processing cracks.

## Acknowledgments

The authors would like to thank M Paranthaman, D E Heatherly and H S Hsu at Oak Ridge National Laboratory for providing Bi-2223 aerosol powders. They would also like to thank the staff of the Superconducting Materials Group at Oak Ridge National Laboratory and University of Houston for their cooperation. This research was sponsored in part by the US Department of Energy, Office of Efficiency and Renewable Energy under contract DE-AC05-96OR22464 with Lockheed Martin Energy Research Corp. and is gratefully acknowledged.

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